

# JXP3416EVRG

## 20V N-Channel Enhancement Mode MOSFET

### DESCRIPTION

The JXP3416EVRG uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and high density cell Design for ultra low on-resistance. This device is suitable for use as a load switch or in PWM applications.

### GENERAL FEATURES

- ◆  $V_{DS} = 20V$ ,  $I_D = 6.5A$
- $R_{DS(ON)}(\text{Typ.}) = 18m\Omega$       @  $V_{GS} = 2.5V$
- $R_{DS(ON)}(\text{Typ.}) = 15m\Omega$       @  $V_{GS} = 4.5V$
- ◆ High power and current handing capability
- ◆ Lead free product is acquired
- ◆ Surface mount package
- ◆ ESD Rating: 3500V HBM

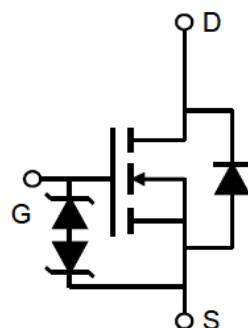
### APPLICATION

- ◆ PWM applications
- ◆ Load switch

### PACKAGE

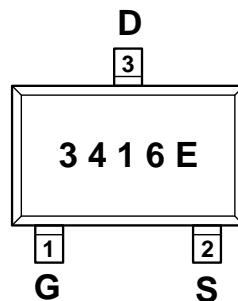
- ◆ SOT-23

### SCHEMATIC DIAGRAM



### PIN ASSIGNMENT

SOT-23  
(TOP VIEW)



### ORDERING INFORMATION

Part Number	Storage Temperature	Package	Marking	Devices Per Reel
JXP3416ERG	-55°C to +150°C	SOT-23	3416E	3000

### ABSOLUTE MAXIMUM RATINGS

( $T_A=25^\circ C$  unless otherwise noted)

parameter	symbol	limit	unit
Drain-source voltage	$V_{DS}$	20	V
Gate-source voltage	$V_{GS}$	$\pm 8$	V
Continuous drain current ( $T_J = 150^\circ C$ ) <sup>a</sup>	$I_D$	6.5	A
		5.2	
Pulsed drain current <sup>b</sup>	$I_{DM}$	30	
Continuous source current (diode conduction) <sup>a</sup>	$I_S$	0.6	
Power dissipation <sup>a</sup>	$P_D$	0.71	W
		0.46	
Operating junction and storage temperature range	$T_J, T_{stg}$	-55—150	°C

## THERMAL CHARACTERISTICS

Parameter	Symbol	Typ	Max	Unit
Maximum junction-to-ambient <sup>a</sup>	≤ 5 s	$R_{\theta JA}$	120	145
	Steady-State		140	175
Maximum junction-to-foot	Steady-State	$R_{\theta JC}$	62	78

### Notes

- a. Surface mounted on 1" x 1" FR4 board
- b. Pulse width limited by maximum junction temperature

## ELECTRICAL CHARACTERISTICS ( $T_A=25^\circ C$ unless otherwise noted)

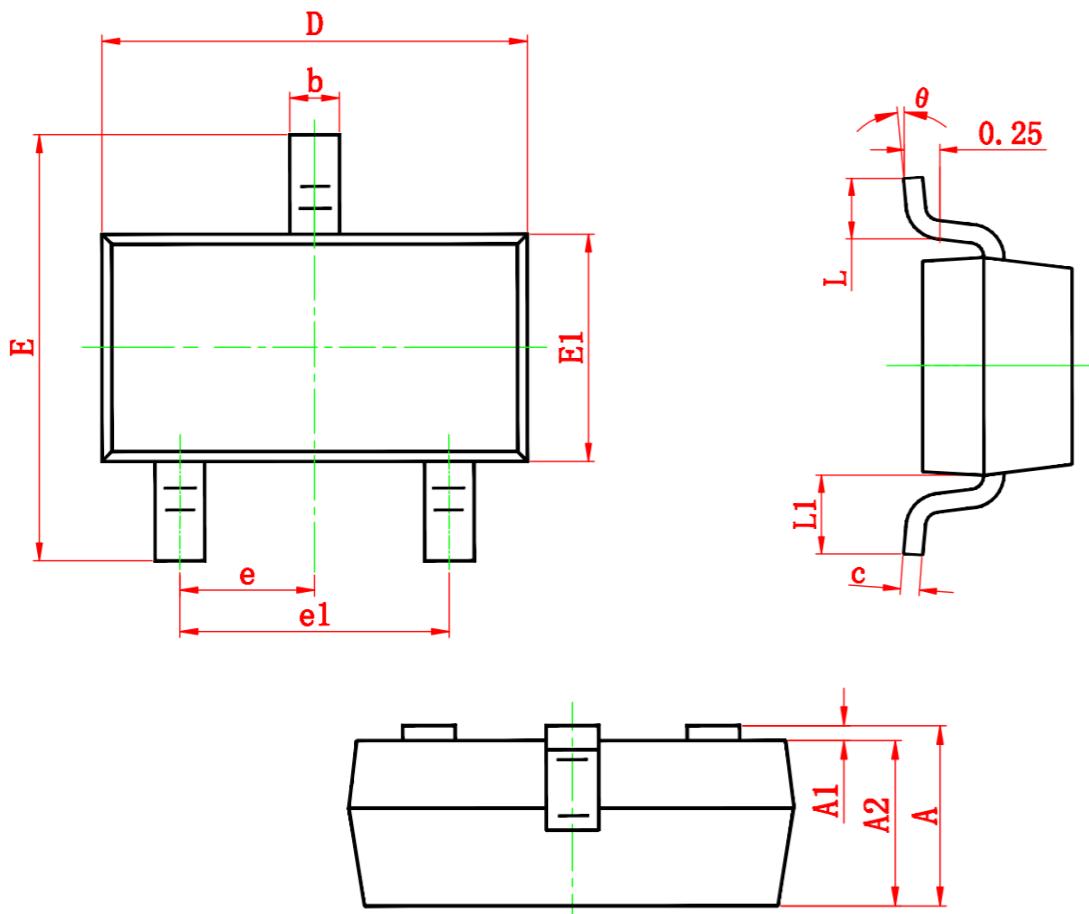
Parameter	Symbol	Condition	Min	Typ	Max	Unit
<b>OFF Characteristics</b>						
Drain-source breakdown voltage	$BV_{DSS}$	$V_{GS}=0V, I_D=250\mu A$	20	-	-	V
Zero gate voltage drain current	$I_{DSS}$	$V_{DS}=20V, V_{GS}=0V$	-	-	1	$\mu A$
Gate-body leakage	$I_{GSS}$	$V_{DS}=0V, V_{GS}=\pm 8V$	-	-	$\pm 10$	$\mu A$
<b>ON Characteristics</b>						
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	0.4	0.7	1.1	V
Drain-source on-state resistance <sup>a</sup>	$R_{DS(ON)}$	$V_{GS}=4.5V, I_D=6.5A$	-	15	22	$m\Omega$
		$V_{GS}=2.5V, I_D=5.5A$		18	26	
Forward transconductance <sup>a</sup>	$g_{fs}$	$V_{DS}=5V, I_D=6.5A$	-	50	-	S
<b>Dynamic Characteristics <sup>b</sup></b>						
Input capacitance	$C_{iss}$	$V_{DS}=10V, V_{GS}=0V$ $f=1.0MHz$	-	1300	-	pF
Output capacitance	$C_{oss}$		-	160	-	
Reverse transfer capacitance	$C_{rss}$		-	87	-	
<b>Switching Characteristics</b>						
Turn-on delay time	$t_{D(ON)}$	$V_{DS}=10V$ $V_{GS}=4.5V$ $R_L=1.54 \text{ ohm}$ $R_{GEN}=3\text{ohm}$	-	280	-	ns
Rise time	$tr$		-	328	-	
Turn-off delay time	$t_{D(OFF)}$		-	3.76	-	
Fall time	$tf$		-	2.24	-	
Total gate charge	$Q_g$	$V_{DS}=10V, I_D=6.5A$ $V_{GS}=4.5V$	-	10	-	nC
Gate-source charge	$Q_{gs}$		-	4.2	-	
Gate-drain charge	$Q_{gd}$		-	2.6	-	
<b>DRAIN-SOURCE DIODE CHARACTERISTICS</b>						
Diode forward voltage	$V_{SD}$	$V_{GS}=0V, I_s=1A$	-	0.72	1.2	V

### Notes

- a. Pulse test: Pulse width  $\leq 300 \mu s$ , duty cycle  $\leq 2 \%$
- b. Guaranteed by design, not subject to production testing

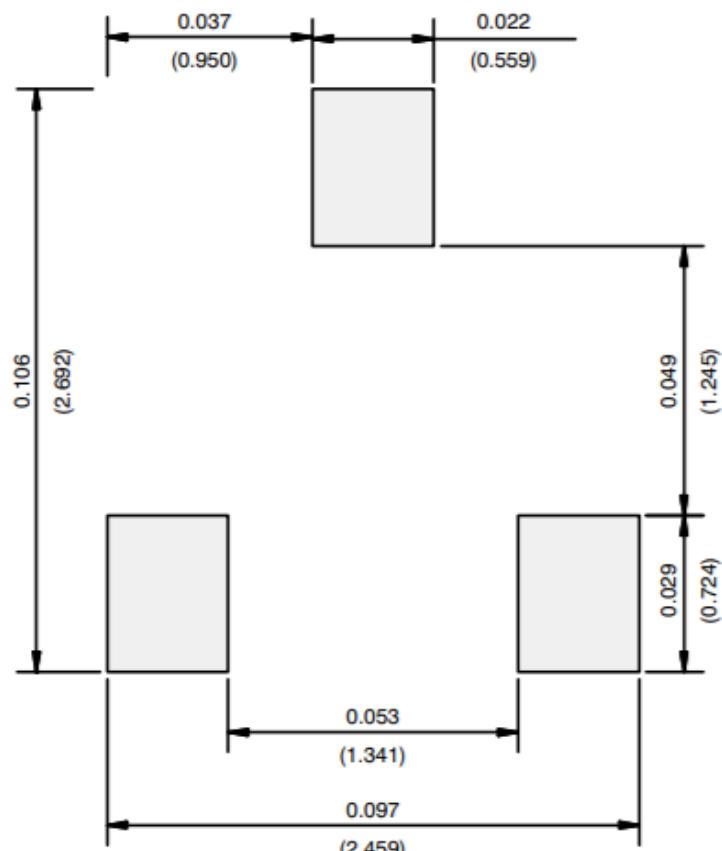
## PACKAGE INFORMATION

- SOT-23



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.900	1.150	0.035	0.045
A1	0.000	0.100	0.000	0.004
A2	0.900	1.050	0.035	0.041
b	0.300	0.500	0.012	0.020
c	0.080	0.150	0.003	0.006
D	2.800	3.000	0.110	0.118
E	2.250	2.550	0.089	0.100
E1	1.200	1.400	0.047	0.055
e	0.950 TYP.		0.037 TYP.	
e1	1.800	2.000	0.071	0.079
L	0.300	0.500	0.012	0.020
L1	0.550 REF.		0.022 REF.	
theta	0°	8°	0°	8°

## RECOMMENDED MINIMUM PADS FOR SOT-23



Recommended Minimum Pads  
Dimensions in Inches/(mm)